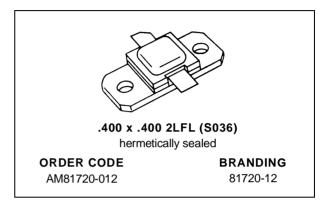


# AM81720-012

# RF & MICROWAVE TRANSISTORS COMMUNICATIONS APPLICATIONS

- REFRACTORY/GOLD METALLIZATION
- EMITTER SITE BALLASTED
- RUGGIZED VSWR ∞:1
- LOW THERMAL RESISTANCE
- INPUT/OUTPUT MATCHING
- OVERLAY GEOMETRY
- METAL/CERAMIC HERMETIC PACKAGE
- P<sub>OUT</sub> = 12 W MIN. WITH 7.4 dB GAIN

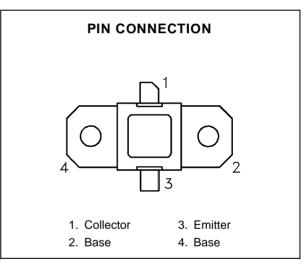


#### **DESCRIPTION**

The AM81720-012 is designed specifically for Telecommunications applications.

The device is capable of withstanding any mismatch load condition at any phase angle (VSWR ∞:1) under full rated conditions. The unit is an overlay, emitter site ballasted, geometry utilizing a refractory/gold metallization system.

The unique AMPAC™ devices are housed in Hermetic Metal/Ceramic packages with internal Input/Output matching structures.



#### **ABSOLUTE MAXIMUM RATINGS** $(T_{case} = 25^{\circ}C)$

Symbol	Parameter Value		Unit
P <sub>DISS</sub>	Power Dissipation*	31.8	W
Ic	Device Current*		Α
Vcc	Collector-Supply Voltage*	24	V
TJ	Junction Temperature	200	°C
T <sub>STG</sub>	Storage Temperature	- 65 to +200	°C

#### THERMAL DATA

R <sub>TH(j-c)</sub> Junction-Case Thermal Resistance	5.5	°C/W
---	-----	------

<sup>\*</sup>Applies only to rated RF amplifier operation

NOTE: Thermal Resistance determined by Infra-Red Scanning of Hot-Spot Junction Temperature at rated RF operating conditions.

September 1992

## **ELECTRICAL SPECIFICATIONS** $(T_{case} = 25^{\circ}C)$

#### **STATIC**

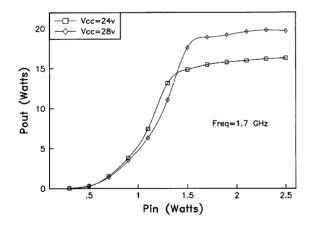
Symbol	Test Conditions	Value			IIn:4		
		Min.	Тур.	Max.	Unit		
ВУсво	$I_C = 5mA$	$I_E = 0mA$		45	_	_	V
BV <sub>EBO</sub>	I <sub>E</sub> = 5mA	$I_C = 0mA$		3.0	_	_	٧
Ісво	V <sub>CB</sub> = 24V			_	_	1.25	mA
h <sub>FE</sub>	V <sub>CE</sub> = 5V	I <sub>C</sub> = 1A		15	_	150	

#### **DYNAMIC**

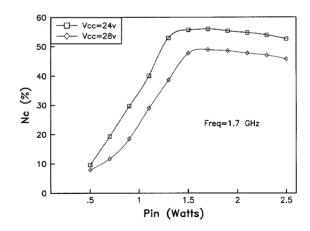
Symbol	Test Conditions		Value		Unit		
Symbol	rest conditions			Min.	Тур.	Max.	Unit
Pout	f = 1.7 — 2.0GHz	$P_{IN} = 2.2W$	$V_{CC} = 24V$	12	_	_	W
ης	f = 1.7 — 2.0GHz	$P_{IN} = 2.2W$	$V_{CC} = 24V$	40			%
G <sub>P</sub>	f = 1.7 — 2.0GHz	$P_{IN} = 2.2W$	$V_{CC} = 24V$	7.4	_	_	dB

#### **TYPICAL PERFORMANCE**

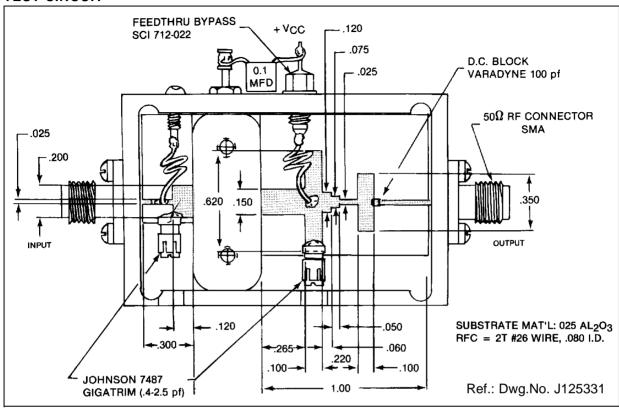
#### **POWER OUTPUT vs POWER INPUT**



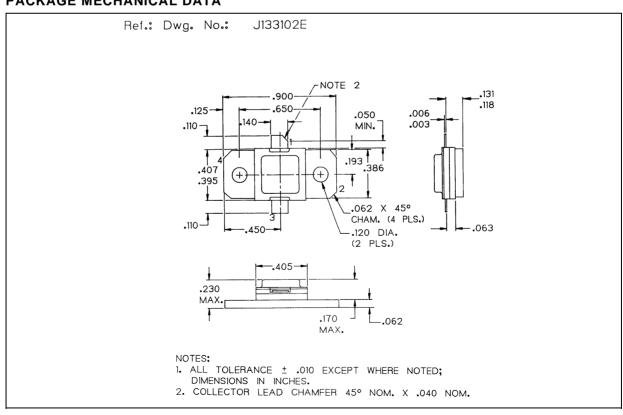
### COLLECTOR EFFICIENCY vs POWER INPUT



#### **TEST CIRCUIT**



### **PACKAGE MECHANICAL DATA**



Information furnished is believed to be accurate and reliable. However, SGS-THOMSON Microelectronics assumes no responsability for the consequences of use of such information nor for any infringement of patents or other rights of third parties which may results from its use. No license is granted by implication or otherwise under any patent or patent rights of SGS-THOMSON Microelectronics. Specifications mentioned in this publication are subject to change without notice. This publication supersedes and replaces all information previously supplied. SGS-THOMSON Microelectronics products are not authorized for use as critical components in life support devices or systems without express written approval of SGS-THOMSON Microelectonics.

© 1994 SGS-THOMSON Microelectronics - All Rights Reserved

SGS-THOMSON Microelectronics GROUP OF COMPANIES

Australia - Brazil - France - Germany - Hong Kong - Italy - Japan - Korea - Malaysia - Malta - Morocco - The Netherlands - Singapore - Spain - Sweden - Switzerland - Taiwan - Thailand - United Kingdom - U.S.A

